Application/Control No. Applicant(s)/Patent Under Reexamination 10/647,419 YOSHIHIRO YAZAWA ET AL Notice of References Cited Examiner Art Unit Page 1 of 1 Deborah Yee 1742 **U.S. PATENT DOCUMENTS** Document Number Date Name Country Code-Number-Kind Code MM-YYYY Classification US-6,645,318 11-2003 Takahashi et al. Α 148/325 US-5,859,095 01-1999 В Moyle et al. 523/402 US-5,677,268 10-1997 С Omosako et al. 508/171 D US-US-Ε US-F US-G US-US-US-J US-K US-L US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code Country Name Classification MM-YYYY Ν 0 Ρ Q R s Т

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